Se	Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/781,442	WU ET AL.
Examiner	Art Unit
Nyeemah Grazier	1626

	SEAD	CHED	•
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Class	Subclass	Date	Examiner
514	422,445	12/7/2006	NG
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INT	INTERFERENCE SEARCHED		
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Updated STN Structure Search online	12/7/2006	NG
Updated Classification Search	12/7/2006	NG
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